

# **Notice of References Cited**

Application/Control No.

10/776,790

Applicant(s)/Patent Under  
Reexamination  
TASAKA ET AL.

Examiner

Sow-Fun Hon

Art Unit

1772

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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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